

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/342,235	TAKEMURA, YASUHIKO	
Examiner	Art Unit	
A. Sefer	2826	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
search updated	6/5/2006	AS		
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